

**Search Notes****Application/Control No.**

09/506,081

**Examiner**

John P. Lacyk

**Applicant(s)/Patent under Reexamination**

CHIU ET AL.

**Art Unit**

3735

**SEARCHED**

Class	Subclass	Date	Examiner
600	1-8		
606	194		
604	507-510,		
	96.01,		
	97.01		
	101.01-		
	103.14	2/3/2006	JPL
Updated	above	8/3/2006	JPL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search History Printout		8/7/2006	JPL